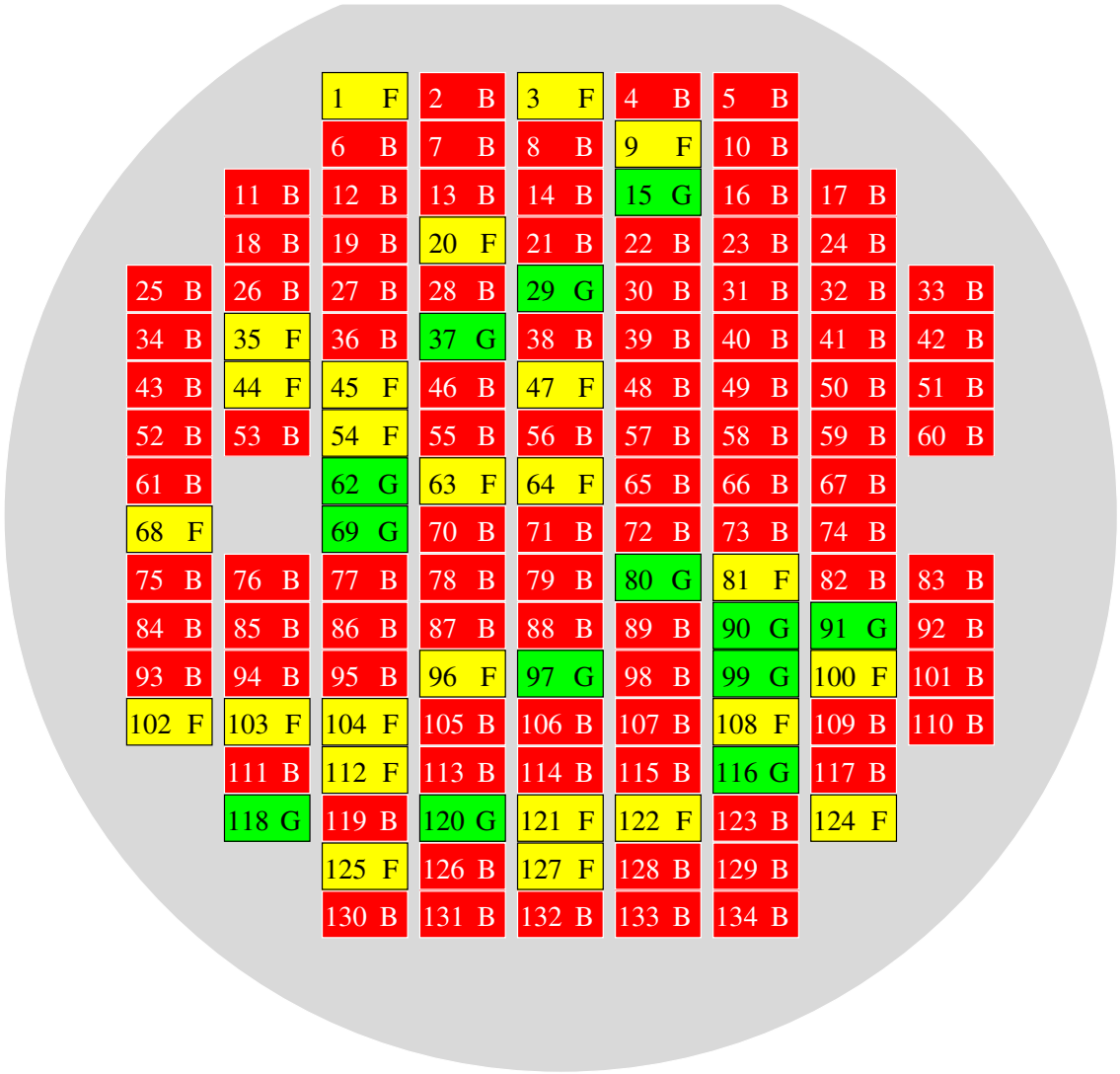
Die quality map for wafer 211 s/n: 21316-15-19

Date: 10/20/99



# B	Bad die
# F	Fair die
# G	Good die
# N	No info
# *	Manually tagged